

## ECE 5205 Homework assignment # 8 (turn in by 4-17-2014)

- 1. Velocity Saturation and saturation current:** Compare ideal MOSFET saturation current (see eq.(1)) with a MOSFET suffering velocity saturation (see eq.(2)) with following parameters  $\mu_n=1000\text{cm}^2/\text{V-sec}$ ,  $C_{ox}=10^{-8}\text{F}/\text{cm}^2$ ,  $W=10\mu\text{m}$ ,  $L=1\mu\text{m}$ ,  $V_T=0.4\text{V}$  and  $v_{sat}=5\times 10^6\text{cm/sec}$ . a) calculate saturation current for both cases for  $V_{gs}=2\text{V}$  and  $V_d=3\text{V}$ ; for which case is the saturation current larger? b) calculate the transconductance for both cases; for which case is the drain current more sensitive to the gate bias? (6 points)
- 2. Mobility:** Consider electrons in a an inversion channel; a) at  $V_{g1}=V_T+2\text{V}$  the mobility due to phonon scattering  $\mu_{ph}=900\text{cm}^2/\text{V-sec}$ , due to impurity scattering  $\mu_i=900\text{cm}^2/\text{V-sec}$ , and due to surface scattering  $\mu_{surf}=900\text{cm}^2/\text{V-sec}$ ; what is the overall channel electron mobility? b) at  $V_{g2}=V_T+4\text{V}$  the phonon mobility and the impurity mobility remain the same, but the surface mobility degrades to  $\mu_{surf}=700\text{cm}^2/\text{V-sec}$ ; what is the overall channel electron mobility? (3 points)
- 3. Channel length modulation:** Consider n-channel MOSFET with substrate doping  $N_A=2\times 10^{16}\text{cm}^{-3}$ ,  $V_T=0.4\text{V}$ ,  $L=1\mu\text{m}$ ,  $V_{gs}=1\text{V}$  and  $V_{ds}=2.5\text{V}$ . Determine the ratio of actual drain current  $I_D$  compared to the ideal value due to channel length modulation. Hint: Use the formula for the length of depletion region between the channel pinch-off and the drain – see corresponding slides in the lecture notes. (3 points)
- 4. The mobility** of electrons in pure GaAs at 300 K is  $8500\text{cm}^2/(\text{Vs})$ . Calculate the mean scattering time. Note that this scattering time is due only to lattice vibrations. If the GaAs sample is doped at  $N_D=10^{17}\text{cm}^{-3}$ , the mobility is measured to decrease to  $5000\text{cm}^2/(\text{Vs})$ . From this information determine the mean scattering time due only to ionized impurity scattering. Assume effective mass of electron in GaAs  $m_{eff}=0.067m_e$ . (4 points)

$$I_{dsat} = \mu_{eff} C_{ox} \frac{W}{2L} (V_g - V_T)^2$$

eq.(1) ideal MOSFET in saturation

$$I_{dsat} = WC_{ox} v_{sat} (V_g - V_T)$$

eq.(2) MOSFET in saturation and subject to velocity saturation

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- 5. Channel conductivity:** Consider a n-MOSFET with  $N_A = 5 \times 10^{16} \text{ cm}^{-3}$ . a) Calculate the channel conductivity near the Si-SiO<sub>2</sub> interface under the flat band condition and at inversion. Assume electron mobility of  $\mu_n = 600 \text{ cm}^2/\text{Vs}$  and hole mobility  $\mu_h = 200 \text{ cm}^2/(\text{Vs})$ . b) calculate the conductivity of an undoped Si with  $\mu_n = 1000 \text{ cm}^2/\text{Vs}$  and  $\mu_h = 350 \text{ cm}^2/(\text{Vs})$ . (4 points)